

SDM3065X Series Digital Multimeter



SDM3065X

SDM3065X-SC

Product Overview

The SDM3065X / SDM3065X-SC is a 6 1/2 digit DMM(digital multimeter with 2,200,000 counts) incorporating a dual -display. The SDM3065X series is especially well-suited for the needs of high-accuracy and high-precision applications measurement.

Application fields

- Research Laboratory
- Development Laboratory
- Detection and Maintenance
- Calibration Laboratory
- Automatic Production Test

Main Function

Basic Measurement Function

- DC Voltage: 200 mV - 1000 V
- DC Current: 200 μ A - 10 A
- AC Voltage: True-RMS, 200 mV - 750 V
- AC Current: True-RMS, 200 μ A - 10 A
- 2/4-Wire Resistance: 200 Ω - 100 M Ω
- Capacitance: 2 nF - 100 mF
- Continuity Test: Range is fixed at 2 k Ω
- Diode Test: Adjustable range is 0 - 4V.
- Frequency Measurement: 3 Hz - 1 MHz
- Period Measurement: 1 μ s - 333.33 ms
- Temperature: Support for TC and RTD sensors

Math Function

- Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement, Pass/Fail Histogram, Trend Chart, Bar Meter, etc.

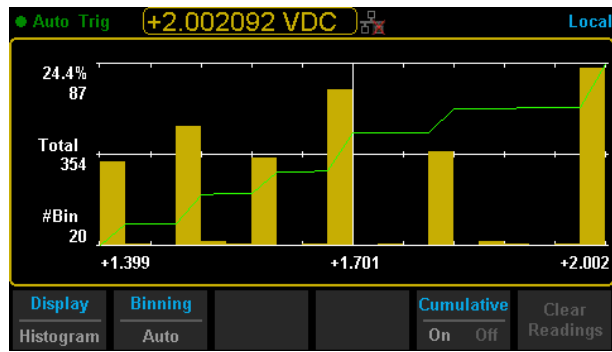
Main Features

- 4.3" TFT-LCD, 480*272
- Real 6 1/2 digits readings resolution (2,200,000 counts)
- 1Gb Nand flash size, Mass storage configuration files and data files
- True-RMS AC Voltage and AC Current measuring
- Supports double display, Chinese and English Menu
- File management (support for U-disc and local storage)
- Built-in cold terminal compensation for thermocouple
- Comes with easy, convenient and flexible any sensor measurement control software: EasyDMM
- Standard interfaces: USB Device, USB Host, LAN (Optional Accessories: USB-GPIB Adapter)
- Scanner Card SC1016 (Only for SDM3065X-SC)
- Standard interfaces: USB Device, USB Host, LAN (Optional Accessories: USB-GPIB Adapter and Scanner Card SC1016)
- Built-in Hlep system makes information acquisition easier
- Support remote control operation via SCPI commands. Compatible with commands of other main stream multimeters
- Supports intelligent management system for laboratory based on BS framework and LAN.

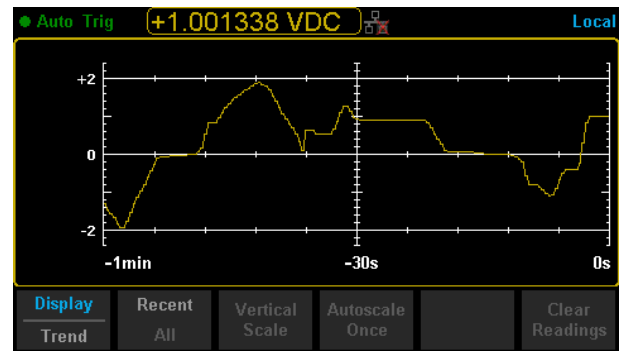


Special Features

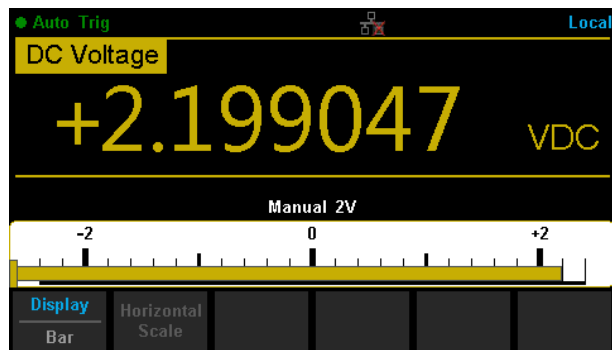
Histogram



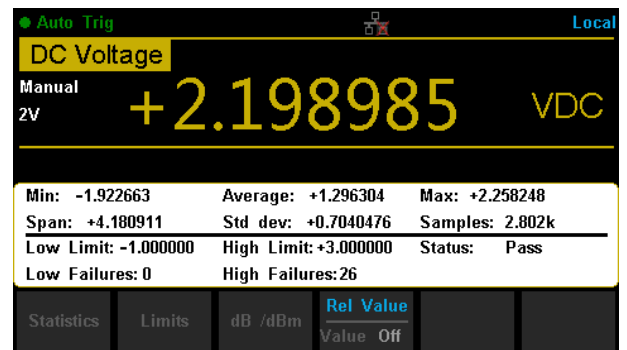
Trend Chart



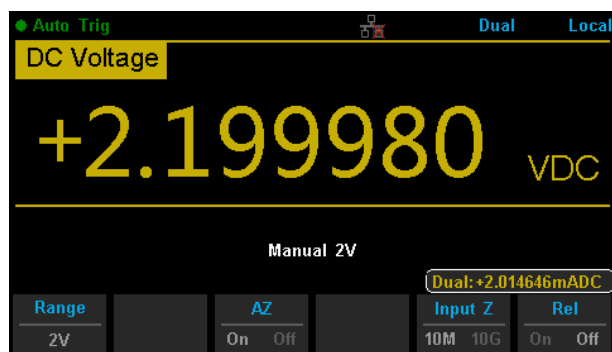
"Analog" Bar Display



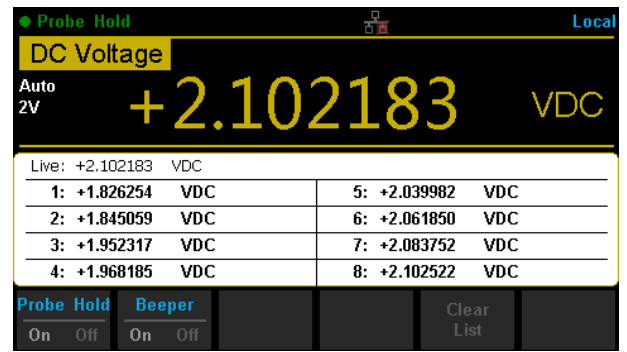
Statistics



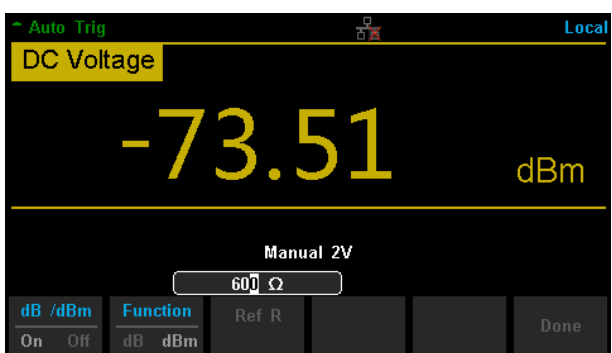
Dual Measurement Display



Hold Measurement



dBm Hold Measurement



Interface



DC Characteristics

Accuracy \pm (% of reading + % of range) ^[1]

Function	Range ^[2]	Test Current Or Burden Voltage	24Hour ^[3] TCAL °C ± 1 °C	90day TCAL °C ± 5 °C	1Year TCAL °C ± 5 °C	Temperature coefficient 0 °C to (TCAL °C -5 °C) (TCAL °C +5 °C) to 50 °C
DC Voltage	200.0000 mV		0.0020 + 0.0015	0.0030 + 0.0020	0.0040 + 0.0023	0.0005 + 0.0003
	2.000000 V		0.0015 + 0.0004	0.0020 + 0.0004	0.0035 + 0.0006	0.0005 + 0.0001
	20.00000 V		0.0020 + 0.0003	0.0030 + 0.0004	0.0040 + 0.0004	0.0005 + 0.0001
	200.0000 V		0.0020 + 0.0005	0.0040 + 0.0004	0.0050 + 0.0005	0.0005 + 0.0001
	1000.000 V ^[4]		0.0020 + 0.0005	0.0040 + 0.0008	0.0055 + 0.0008	0.0005 + 0.0001
DC Current	200.0000 μ A	< 0.03V	0.009 + 0.010	0.040 + 0.005	0.050 + 0.005	0.0020 + 0.0026
	2.000000 mA	< 0.25V	0.007 + 0.001	0.030 + 0.001	0.050 + 0.002	0.0020 + 0.0001
	20.00000 mA	< 0.07 V	0.006 + 0.008	0.030 + 0.005	0.050 + 0.005	0.0020 + 0.0015
	200.0000 mA	< 0.7V	0.009 + 0.001	0.030 + 0.001	0.050 + 0.002	0.0020 + 0.0001
	2.000000 A	< 0.12 V	0.045 + 0.015	0.080 + 0.005	0.100 + 0.012	0.0050 + 0.0008
	10.00000 A ^[5]	< 0.6 V	0.090 + 0.002	0.120 + 0.005	0.150 + 0.005	0.0050 + 0.0018
Resistance ^[6]	200.0000 Ω	1 mA	0.0030 + 0.0031	0.008 + 0.005	0.010 + 0.004	0.0006 + 0.0006
	2.000000 K Ω	1 mA	0.0020 + 0.0005	0.008 + 0.001	0.010 + 0.001	0.0006 + 0.0001
	20.00000 K Ω	100 μ A	0.0020 + 0.0005	0.008 + 0.001	0.010 + 0.001	0.0006 + 0.0001
	200.0000 K Ω	10 μ A	0.0020 + 0.0005	0.008 + 0.001	0.010 + 0.001	0.0006 + 0.0001
	1.000000 M Ω	2 μ A	0.0020 + 0.0010	0.010 + 0.001	0.012 + 0.001	0.0010 + 0.0002
	10.00000 M Ω	200 nA	0.015 + 0.001	0.030 + 0.001	0.040 + 0.001	0.0030 + 0.0005
	100.0000 M Ω	200 nA 10 M Ω	0.300 + 0.010	0.800 + 0.010	0.800 + 0.010	0.1500 + 0.0002
Diode Test ^[7]	0~ 2V	1 mA	0.002 + 0.009	0.008 + 0.020	0.010 + 0.020	0.0010 + 0.0020
	2~ 4V	1 mA	0.002 + 0.010	0.008 + 0.020	0.010 + 0.020	0.0010 + 0.0020
Continuity Test	2000.0 Ω	1 mA	0.002 + 0.010	0.008 + 0.020	0.010 + 0.020	0.0010 + 0.0020

Remarks:

- [1] Specifications are for 90-minute warm-up and 100NPLC integration time. For integration time <100NPLC, add the appropriate "RMS Noise Adder" listed in the following table.
- [2] 10% over range on all ranges except DCV 1000V and DCI 10A range.
- [3] Relative to calibration standards.
- [4] For each additional volt over ± 500 V, add 0.03mV error.
- [5] For continuous current > 7A DC or 7A AC RMS, 30 seconds ON and 30 seconds OFF.
- [6] Specifications are for 4-wire resistance measurement or 2-wire resistance measurement using REL operation. Without REL operation, add 0.2 Ω additional error in 2-wire resistance measurement.
- [7] Accuracy specifications for the voltage measured at the input terminal only. 1 mA test current is typical. Variation in the current source will create some variation in the voltage drop across a diode junction. Adjustable voltage range : 0~ 4V.

Performance Versus Integration Time – 50 Hz (60 Hz) Power-line Frequency

Integration Time	Resolution ^[1]	NMRR ^[2]	Readings/s ^[3]		RMS Noise Adder ^[4] (% of Range)			
			50Hz	60Hz	DCV 20V	DCV 2V 200V Resistance 2KΩ 20KΩ	DCV 1000V DCI 2 mA 200mA	DCV 200mV Resistance 200Ω DCI 10A
Number of Power line Cycles ^[5] (NPLC)	(ppm Range)	(dB)						
0.005(0.006)	2.7	0	10000	10000	0.0006	0.0008	0.0015	0.0040
0.05 (0.06)	1.6	0	1000	1000	0.0004	0.0005	0.0008	0.0025
0.5 (0.6)	1	0	100	100	0.0003	0.0003	0.0006	0.0025
1	0.22	60	50	60	0	0.0001	0.0002	0.0005
10	0.08	60	5	6	0	0	0	0.0002
100	0.035	60	0.5	0.6	0	0	0	0

Remarks:

[1] Typical value. Resolution is defined as the typical 20V range RMS noise.

[2] Normal mode rejection ratio for power-line frequency $\pm 0.1\%$. For power-line frequency $\pm 1\%$, subtract 20 dB. For $\pm 3\%$, subtract 30dB.

[3] Maximum rate for DCV, DCI, 2-wire resistance and 4-wire resistance functions.

[4] The basic DC accuracy specifications include RMS noise at 100 NPLC. For <100 NPLC, add "RMS Noise Adder" to the basic DC accuracy specifications.

[5] When Power Supply of frequency is 60Hz, the cycles is 0.006, 0.06, 0.6,1,10,100 NPLC.

SFDR & SINAD^[1]

Function	Range	Spurious-Free Dynamic Range (SFDR)	Signal-to-Noise-and-Distortion (SINAD)
DCV	200mV	80	75
	2V	76	80
	20V	78	72
	200V	80	78
	1000V	82	80
DCI	200uA	90	70
	2mA	90	80
	20mA	85	70
	200mA	80	75
	2A	70	60

[1] Typical value. -1dBFS, 1k Hz single tone. 100 us aperture time and auto zero off.

AC Characteristics

Accuracy \pm (% of reading + % of range)^[1]

Function	Range ^[2]	Frequency Range	24 Hour ^[3] TCAL °C $\pm 1^\circ\text{C}$	90 Day TCAL °C $\pm 5^\circ\text{C}$	1 Year TCAL °C $\pm 5^\circ\text{C}$	Temperature coefficient 0 °C to (TCAL °C -5 °C) (TCAL °C +5 °C) to 50 °C
True-RMS AC Voltage ^[4]	200.0000mV	3Hz- 5Hz	1.00 + 0.03	1.00 + 0.04	1.00 + 0.04	0.100 + 0.004
		5Hz-10Hz	0.35 + 0.03	0.35 + 0.04	0.35 + 0.04	0.035 + 0.005
		10Hz-20kHz	0.04 + 0.03	0.05 + 0.04	0.06 + 0.04	0.005 + 0.004
		20kHz-50kHz	0.10 + 0.05	0.11 + 0.05	0.12 + 0.05	0.011 + 0.005
		50kHz-100kHz	0.55 + 0.08	0.60 + 0.08	0.60 + 0.08	0.060 + 0.008
		100kHz- 300kHz	4.00 + 0.50	4.00 + 0.50	4.00 + 0.50	0.20 + 0.02
	2.000000 V	3Hz- 5Hz	1.00 + 0.02	1.00 + 0.03	1.00 + 0.03	0.100 + 0.003
		5Hz-10Hz	0.35 + 0.02	0.35 + 0.03	0.35 + 0.03	0.035 + 0.003
		10Hz-20kHz	0.04 + 0.02	0.05 + 0.03	0.06 + 0.03	0.005 + 0.003
		20kHz-50kHz	0.10 + 0.04	0.11 + 0.05	0.12 + 0.05	0.011 + 0.005
		50kHz-100kHz	0.55 + 0.08	0.60 + 0.08	0.60 + 0.08	0.060 + 0.008
		100kHz- 300kHz	4.00 + 0.50	4.00 + 0.50	4.00 + 0.50	0.20 + 0.02
	20.00000 V	3Hz- 5Hz	1.00 + 0.03	1.00 + 0.04	1.00 + 0.04	0.100 + 0.004
		5Hz-10Hz	0.35 + 0.03	0.35 + 0.04	0.35 + 0.04	0.035 + 0.004
		10Hz-20kHz	0.04 + 0.04	0.07 + 0.04	0.08 + 0.04	0.008 + 0.004
		20kHz-50kHz	0.10 + 0.05	0.12+ 0.05	0.15 + 0.05	0.012 + 0.005
		50kHz-100kHz	0.55 + 0.08	0.60 + 0.08	0.60 + 0.08	0.060 + 0.008
		100kHz- 300kHz	4.00 + 0.50	4.00 + 0.50	4.00 + 0.50	0.20 + 0.02
	200.0000 V	3Hz- 5Hz	1.00 + 0.02	1.00 + 0.03	1.00 + 0.03	0.100 + 0.003
		5Hz-10Hz	0.35 + 0.02	0.35 + 0.03	0.35 + 0.03	0.035 + 0.003
		10Hz-20kHz	0.04 + 0.02	0.07 + 0.03	0.08 + 0.03	0.008 + 0.003
		20kHz-50kHz	0.10 + 0.04	0.12+ 0.05	0.15 + 0.05	0.012 + 0.005
		50kHz-100kHz	0.55 + 0.08	0.60 + 0.08	0.60 + 0.08	0.060 + 0.008
		100kHz- 300kHz	4.00 + 0.50	4.00 + 0.50	4.00 + 0.50	0.20 + 0.02
750.0000V ^[5]	3Hz- 5Hz	1.00 + 0.02	1.00 + 0.03	1.00 + 0.03	0.100 + 0.003	
	5Hz-10Hz	0.35 + 0.02	0.35 + 0.03	0.35 + 0.03	0.035 + 0.003	
	10Hz-20kHz	0.04 + 0.02	0.07 + 0.03	0.08 + 0.03	0.008 + 0.003	
	20kHz-50kHz	0.10 + 0.04	0.12+ 0.05	0.15 + 0.05	0.012 + 0.005	
	50kHz-100kHz	0.55 + 0.08	0.60 + 0.08	0.60 + 0.08	0.060 + 0.008	
	100kHz- 300kHz	4.00 + 0.50	4.00 + 0.50	4.00 + 0.50	0.20 + 0.02	

Function	Range ^[2]	Frequency Range	24 Hour ^[3] TCAL °C ±1°C	90 Day TCAL °C ±5°C	1Year TCAL °C ±5°C	Temperature coefficient 0°C to (TCAL°C -5°C)) TCAL°C +5°C) to 50°C
True-RMS AC Current ^[8]	200.0000 uA	3Hz- 5Hz	1.10 + 0.06	1.10 + 0.06	1.10 + 0.06	0.200 + 0.005
		5Hz-10Hz	0.35 + 0.06	0.35 + 0.06	0.35 + 0.06	0.100 + 0.005
		10Hz-5kHz	0.15 + 0.06	0.15 + 0.06	0.15 + 0.06	0.015 + 0.005
		5kHz-10kHz	0.35 + 0.70	0.35 + 0.70	0.35 + 0.70	0.030 + 0.005
	2.000000mA	3Hz- 5Hz	1.00 + 0.04	1.00 + 0.04	1.00 + 0.04	0.100 + 0.005
		5Hz-10Hz	0.30 + 0.04	0.30 + 0.04	0.30 + 0.04	0.035 + 0.005
		10Hz-5kHz	0.12 + 0.04	0.12 + 0.04	0.12 + 0.04	0.015 + 0.005
		5kHz-10kHz	0.20 + 0.25	0.20 + 0.25	0.20 + 0.25	0.030 + 0.005
	20.00000mA	3Hz- 5Hz	1.10 + 0.06	1.10 + 0.06	1.10 + 0.06	0.200 + 0.005
		5Hz-10Hz	0.35 + 0.06	0.35 + 0.06	0.35 + 0.06	0.100 + 0.005
		10Hz-5kHz	0.15 + 0.06	0.15 + 0.06	0.15 + 0.06	0.015 + 0.005
		5kHz-10kHz	0.35 + 0.70	0.35 + 0.70	0.35 + 0.70	0.030 + 0.005
	200.0000mA	3Hz- 5Hz	1.00 + 0.04	1.00 + 0.04	1.00 + 0.04	0.100 + 0.006
		5Hz-10Hz	0.30 + 0.04	0.30 + 0.04	0.30 + 0.04	0.035 + 0.006
		10Hz-5kHz	0.10 + 0.04	0.10 + 0.04	0.10 + 0.04	0.015 + 0.006
		5kHz-10kHz	0.20 + 0.25	0.20 + 0.25	0.20 + 0.25	0.030 + 0.006
	2.000000 A	3Hz- 5Hz	1.10 + 0.06	1.10 + 0.06	1.10 + 0.06	0.100 + 0.006
		5Hz-10Hz	0.35 + 0.06	0.35 + 0.06	0.35 + 0.06	0.035 + 0.006
		10Hz-5kHz	0.15 + 0.06	0.15 + 0.06	0.15 + 0.06	0.015 + 0.006
		5kHz-10kHz	0.35 + 0.70	0.35 + 0.70	0.35 + 0.70	0.030 + 0.006
10.00000A ^[5]	3Hz- 5Hz	1.10 + 0.08	1.10 + 0.10	1.10 + 0.10	0.100 + 0.008	
	5Hz-10Hz	0.35 + 0.08	0.35 + 0.10	0.35 + 0.10	0.035 + 0.008	
	10Hz-5kHz	0.15 + 0.08	0.15 + 0.10	0.15 + 0.10	0.015 + 0.008	

Additional Low Frequency Errors (% of reading)				Additional Crest Factor Errors (non-sine wave) ^[7]	
Frequency	AC Filter			Crest Factor	error(% of reading)
	> 3Hz	> 20 Hz	> 200Hz		
10Hz-20Hz	0	0.74	--	1 - 2	0.05
20Hz-40Hz	0	0.22	--	2 - 3	0.2
40Hz-100Hz	0	0.06	0.73	3 - 4	0.4
100Hz- 200Hz	0	0.01	0.22	4 - 5	0.5
200Hz-1kHz	0	0	0.18		
> 1kHz	0	0	0		

Remarks:

[1] Specifications are for 90-minute warm-up, > 3Hz ac filter and sine wave input.

[2] 10% over range on all ranges except ACV 750 V and ACI 10 A ranges.

[3] Relative to calibration standards.

[4] Specifications are for sine wave input >5% of range. For inputs within 1% and 5% of range and <50 kHz, add 0.1% of range additional error. For 50 kHz to 100k Hz, add 0.13% of range additional error.

[5] ACV 750 range limited to 8×10^7 Volt-Hz. For input over 300V rms, add 0.7mV error for each additional volt.

[6] For continuous current > DC 7A or AC RMS 7A, 30 seconds ON and 30 seconds OFF.

[7] For frequency below 100 Hz, the specification of slow filter is only for sine wave input.

[8] Specifications are for sine wave input >5% of range. For inputs within 1% to 5% of range, add 0.1% of range additional error. Specifications are typical values for 200uA and 2mA, 2A and 10A ranges when frequency >1k Hz.

Frequency and Period Characteristics

Accuracy± (% of Reading)^{[1][2]}

Function	Range	Frequency Range	24 Hour ^[3] TCAL °C ±1 °C	90 Day TCAL °C ±5 °C	1 Year TCAL °C ±5 °C	Temperature coefficient 0 °C to (TCAL °C - 5 °C) (TCAL °C + 5 °C) to 50 °C
Frequency, Period	200 mV to 750 V	3 Hz – 5Hz	0.07	0.07	0.07	0.005
		5 Hz – 10 Hz	0.04	0.04	0.04	0.005
		10 Hz – 40 Hz	0.02	0.02	0.02	0.001
		40 Hz – 300 KHz	0.005	0.006	0.007	0.001
		300 KHz – 1 MHz	0.005	0.006	0.007	0.001

Frequency	Gate Time (Resolution)			
	1s (0.1ppm)	0.1 s (1ppm)	0.01 s (10ppm)	0.001 s (100ppm)
3 Hz– 5Hz	0	0.12	0.12	0.12
5 Hz– 10 Hz	0	0.17	0.17	0.17
10 Hz–40 Hz	0	0.20	0.20	0.20
40 Hz–100 Hz	0	0.06	0.21	0.21
100 Hz–300 Hz	0	0.03	0.21	0.21
300Hz–1 KHz	0	0.01	0.07	0.07
> 1 K Hz	0	0	0.02	0.02

Remarks:

[1] Specifications are for 90 minutes warm-up, using 1s gate time.

[2] For frequency ≤ 300 kHz, the specification is the 10% to 110% of range of the AC input voltage. For frequency > 300 kHz, the specification is the 20% to 110% of range of the AC input voltage. The maximum input is limited to 750V rms or 8×10^7 Volts-Hz (whichever is less). The 200 mV range is full range input or input that is larger than the full range. For 20mV to 200mV, multiply % of reading error ×10.

[3] Relative to calibration standards.

Capacitance Characteristic

Accuracy± (% of Reading + % of Range)^[1]

Function	Range ^[2]	Test Current	1 Year TCAL °C ±5 °C	Temperature coefficient 0 °C to (TCAL °C - 5 °C) (TCAL °C + 5 °C) to 50 °C
Capacitance	2.0000 nF	10 μA	2 + 2.4	0.05 + 0.06
	20.000 nF	10 μA	1 + 0.1	0.05 + 0.01
	200.00 nF	100μA	1 + 0.1	0.01 + 0.01
	2.0000μF	100μA	1 + 0.1	0.01 + 0.01
	20.000μF	1 mA	1 + 0.1	0.01 + 0.01
	200.00μF	1 mA	1 + 0.1	0.01 + 0.01
	2.0000 mF	1 mA	1 + 0.1	0.01 + 0.01
	20.000 mF	1 mA	1 + 0.1	0.01 + 0.01
	100.00 mF	1 mA	3 + 0.1	0.05 + 0.02

Remarks:

[1] Specifications are for 90 minutes warm-up and using REL operation. Additional errors may be caused by non-film capacitors.

[2] Specifications are the 1% to 110% of range on 2nF range and 10% to 110% of range on all other ranges

Temperature Characteristics

Accuracy± (% of Reading)^[1]

Function	Probe Type	Type	Optimum Range	1 Year TCAL °C ±5°C	Temperature coefficient 0°C to (TCAL °C - 5°C) (TCAL °C + 5°C) to 50°C
Temperature	RTD ^[2] (R0 is 49Ω to 2.1kΩ)	α=0.00385	-200°C ~ 660°C	0.16°C	0.01°C
		B	0°C ~ 1820°C	0.76 °C	0.14°C
	Thermocouple ^[3]	E	-270°C ~ 1000°C	0.5°C	0.02°C
		J	-210°C ~ 1200°C	0.5°C	0.02°C
		K	-270°C ~ 1370°C	0.5°C	0.03°C
		N	-270°C ~ 1300°C	0.5°C	0.04°C
		R	-270°C ~ 1760°C	0.5°C	0.09°C
		S	-270°C ~ 1760°C	0.6°C	0.11°C
		T	-270°C ~ 400°C	0.5°C	0.03°C

Remarks:

[1] Specifications are for 90 minutes warm-up. Exclusive of sensor error.

[2] Specification is for 4WR sensor measurement or 2WR measurement using REL operation.

[3] Relative to cold junction temperature, accuracy is based on ITS-90. Built-in cold junction temperature refers to the temperature inside the banana jack and its accuracy is ± 2.5 °C .

Measurement Rate

Measurement rate^[3]

Function	Setting	Integration	Readings/s 50Hz (60Hz)
DC Voltage DC Current 2 - wire Resistance 4 - wire Resistance	0.005 (0.006) NPLC	100(100)us	10000 (10000)
	0.05 (0.06) NPLC	1 (1)ms	1000 (1000)
	0.5 (0.5) NPLC	4 (4)ms	100 (100)
	1 NPLC	20(16.7)ms	50 (60)
	10 NPLC	200(167)ms	5 (6)
	100 NPLC	2(1.67)s	0.5 (0.6)
AC Voltage AC Current	3Hz AC Filter		0.5
	20Hz		2
	200Hz		50
Frequency and Period ^[1]	1s Gate time		1
	0.1s		10
	0.01s		100
	0.001s		500
Capacitance ^[2]	100mF Range		0.5

Remarks:

[1] 20 V range, 1k Hz input.

[2] The measurement period changes with the capacitance under test.

[3] Auto zero off , auto range off.

Measuring Method and other Characteristics

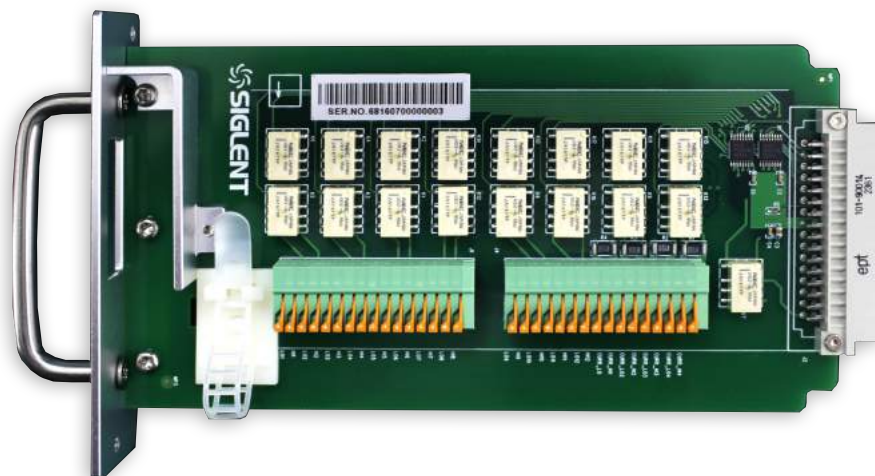
DC Voltage	
Input Resistance	200 mV, 2 V, 20 V ranges: Selectable 10 M Ω or > 10 G Ω (For these ranges, input beyond ± 26 V are clamped through 106 k Ω (typical))
	200 V and 1000 V ranges: 10 M Ω \pm 1%
Input Offset Current	50 pA, 25 $^{\circ}$ C ,typical
Input Protection	1000 V
CMRR (common mode rejection ratio)	140 dB for 1 k Ω unbalance in LO lead, \pm 500 VDC peak maximum
Resistance	
Measurement Method	Selectable 4-wire or 2-wire resistance
	Current source referenced to LO input
Open-circuit Voltage	Limited to <10V
Max. Lead Resistance (4-wire)	10% of range per lead for 200 Ω , 2 k Ω ranges, 1 k Ω per lead on all other ranges
Offset Compensation	Available on 200 Ω , 2k Ω and 20 k Ω ranges
Input Protection	1000 V on all ranges
DC Current	
Shunt Resistor	100 Ω for 200 u A, 2 m A
	1 Ω for 20 m A , 200 m A
	0.01 Ω for 2 A, 10 A
Input Protection	Rear panel : accessible 10 A,250 V Time-Lag fuse
	Internal 12A, 250V Time-Lag fuse
Continuity / Diode Test	
Measurement Method	1 m A \pm 5% constant-current source or open-circuit voltage
Response Time	300 samples/sec, with audible tone
Beeper	Yes
Diode Threshold	Adjustable from 0 to 4 V
Continuity Threshold	Adjustable from 1 Ω to 2 K Ω
Input Protection	1000 V
Settling Time Considerations	
Reading settling times are affected by source impedance, cable dielectric characteristics and input signal changes. The default measurement delay is selected to the correct reading for most measurements.	
Measurement Considerations	
Teflon or other high-impedance, low-dielectric absorption wire insulation is recommended for these measurements	
True RMS AC Voltage	
Measurement Method	AC-coupled True-RMS measurement with up to 400 V DC of bias at on any range.
Crest Factor	\leq 5 at full range
Input Impedance	1M Ω \pm 2% in parallel with <150pF capacitance on any range
Input Protection	750V rms on all ranges
AC Filter Bandwidth	Slow : 3 Hz \sim 300 KHz
	Medium : 20 Hz \sim 300 KHz
	Fast : 200 Hz \sim 300 KHz
CMRR (common mode rejection ratio)	70 dB, for the 1 k Ω unbalance in LO lead, < 60 Hz, \pm 500 VDC peak maximum

True RMS AC Current	
Measurement Method	Direct coupled to the fuse and shunt; AC-coupled True RMS measurement (Measure the AC component only).
Crest Factor	≤ 3 at full range
Max. Input	DC + AC current peak value < 300% of range. The RMS current < 10 A rms including the DC component.
Shunt Resistor	100Ω for 200uA , 2mA
	1Ω for 20mA,200mA
	0.01Ω for 2A,10A
Input Protection	Externally accessible 10A,250V Time-Lag fuse
	Internal 12A, 250 V Time-Lag fuse
Settling Time Considerations	
<p>The default measurement delay is selected to give first reading correctly for most measurements. Make sure the RC circuit of input terminal has been fully settled (about 1s) before reading the accurate measurement.</p> <p>Applying > 300 Vrms (or > 5Arms) will cause self-heating in signal-conditioning components and these errors are included in the instrument specifications. Internal temperature changes due to self-heating may cause additional errors on lower AC voltage ranges. The additional error will be lower than 0.02% of reading and will generally dissipate within a few minutes.</p>	
Frequency and Period	
Measurement Method	Reciprocal-counting technique, AC-coupled input using the AC voltage function.
Input Impedance	1 MΩ ± 2% in parallel with < 150 pF capacitance on any range
Input Protection	750 V rms on all ranges
Measurement Considerations	All frequency counters are susceptible to error when measuring low-voltage, low-frequency signals. Shielding inputs from external noise is recommended
Settling Time Considerations	Errors will occur when attempting to measure the frequency or period of an input following a dc offset voltage change. Make sure the RC circuit of input terminal has been fully settled (about 1s) before reading the accurate measurement.
Capacitance Measurement	
Measurement Method	Apply constant current into the capacitance, and measure the voltage changing rate.
Connection Type	2-wire
Input Protection	1000 V on all ranges
Measurement considerations	Since small capacitance measurements are susceptible to the external noise, shielding inputs from external noise pickup is critical for minimizing measurement errors.
Temperature Measurement	
Measurement Method	Support for TC and RTD types of sensor
Measurement considerations	The built-in cold junction temperature tracks the temperature inside the banana jack. The change of the temperature in banana jack may cause additional error. When using the built-in cold junction compensation, connect the sensor terminal of the thermocouple to the banana jack and allow it warm up for more than 3 minutes to minimize the error.

Triggering and Storage	
Trigger	Pre-trigger or Post-trigger, Internal Trigger or External Trigger, Rising Edge Trigger or Falling Edge Trigger
Time Base Resolution	40us, 0.01% Accuracy
Trigger Delay	0 to 1000s
Reading Sensitivity	0.01%、0.1%、1% or 10% reading
Single Trigger Samples	1 to 599999999
External Trigger Input	Level: TTL compatible
	Trigger: Selectable rising edge or falling edge
	Input Impedance: $\geq 30K\Omega//500pF$
	Delay: < 50 μ s
	Maximum Rate: 300/s
	Minimum Pulse Width: 2 μ s
VMC Output	Level: 5V TTL Compatible
	Output Polarity: Positive and negative optional
	Output Impedance : 200 Ω , typical
	Pulse Width: about 2 μ s
History Records	
Volatile Memory	10K reading of history records
Nonvolatile Memory	1Gb Nand Flash, Mass storage configuration files and data files, Supports U-disk external storage
Math Functions	
Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, Histogram, Trend chart, Bar chart	
General Specifications	
Power Supply	
AC 100 V ~ 120 V	45 Hz — 66 Hz
AC 200 V ~ 240 V	45 Hz — 66 Hz
Detect the power-line frequency automatically at power-on, 400Hz defaults to 50Hz	
Power Consumption	25VA max
Mechanism	
Dimension	(length×width×height): 345.45mm×260.29mm×107.21mm
Weight	3.377Kg (Net weight)
Other characteristics	
Display Screen	4.3 "TFT-LCD with resolution 480*272
Working Environment	Full accuracy for 0 °C to 50 °C
	Full accuracy to 40 °C , 80% R.H., Non-coagulation
	Storage Temperature — 20°C to 70°C
	Shock and Vibration: conforming to MIL-T-28800E, III, 5 level (only for sine)
	Height above sea level: up to 3000 meters
EMC	Conforming to EMC (2004/108/EC) and EN 61326-1:2013
Safety	IEC 61010-1; EN 61010-1; UL 61010-1; CAN/CSA-C22.2 No. 61010-1 Measurement CAT I 1000 V/CAT II 600 V
Remote Interface	10/100Mbit LAN, USB2.0 Full Speed Device, Host
Programming Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	90 minutes

Scanner card SC1016 (Only for SDM3065X-SC)

The SIGLENT Scanner Card SC1016 is a multiplexer that provides multi-point measurement capabilities to the SDM3065X-SC. The scanner features 12 multi-purpose + 4 current channels and supports the following measurement functions: DCV, ACV, DCI, ACI, 2WR, 4WR, CAP, FREQ, DIODE, CONT and TEMP (RTD and Thermocouple). It provides a convenient and versatile solution for test applications that require multiple measurement points or signals and is an ideal tool for R&D burn-in and production testing.



Specifications

To achieve the best performance from the product, please read this guide carefully.

Max AC Voltage	125V rms or 175V peak, 100kHz, 0.3 A switched, 125VA (resistive load)
Contact Life	> 100000 operations, at 1A 30VDC(at 0.5 Hz) > 100000 operations, at 0.3A 125VDC (at 0.5 Hz)
Contact Resistance	75 mΩ (maximum at 6VDC, 1A)
Actuation Time	180ms maximum on/off (channel to channel)
Maximum switching voltage	250 VAC, 220 VDC
Maximum switching power	62.5VA / 30W
Insulation Resistance	Minimum 1GΩ (500VDC)
Connector Type	Clamp terminal, #24 AWG wire size

Remarks: To avoid electrical shock and personal injury, please don't use the product to measure signals that exceed the published specification.

Channel Capabilities

Item	No. of wires	No. of channels
DCV , ACV ^[1]	2 wires (H , L)	12 (CH1 ~ CH12)
DCI , ACI ^[2]	2 wires (H , L)	4 (CH13 ~ CH16) (2A Range Only)
2W Resistance	2 wires (H , L)	12 (CH1 ~ CH12)
4W Resistance	4 wires (Input H , L + sense H , L)	6 pairs (CH1 [input] & CH7[sense], 2&8, •••, 6&12)
Capacitance	2 wires (H , L)	12 (CH1 ~ CH12)
Diode/Continuity	2 wires (H , L)	12 (CH1 ~ CH12)
Period/Frequency	2 wires (H , L)	12 (CH1 ~ CH12)
Temp(Thermocouple)	2 wires (H , L)	12 (CH1 ~ CH12)
Temp (RTD)	2 wires (H , L)	12 (CH1 ~ CH12)

Remarks:[1]Voltage range : <125VAC , 110VDC

[2] For continuous current < 2.2A, Accuracy ± (% 3 (reading) + 0.02% (range)).

Product Model and Distinction

Model	SDM3065X	SDM3065X-SC
Scanner card SC1016	×	√

Ordering Information

Standard Accessories	
Power Cord -1	
USB Cable -1	
Quick Start -1	
warranty Card -1	
EasyDMM ^[1]	software system
Test Leads and Alligator Clips -2	
Optional Accessories	
USB-GPIB	USB-GPIB adapter

[1] The latest version of EasyDMM can be downloaded for free from the SDM3000 series of digital multimeter. Please see our web site at www.siglent.com for more information

SDM3065X Series Digital Multimeter

About SIGLENT

SIGLENT is an international high-tech company, concentrating on R&D, sales, production and services of electronic test & measurement instruments.

SIGLENT first began developing digital oscilloscopes independently in 2002. After more than a decade of continuous development, SIGLENT has extended its product line to include digital oscilloscopes, function/arbitrary waveform generators, digital multimeters, DC power supplies, spectrum analyzers, isolated handheld oscilloscopes and other general purpose test instrumentation. Since its first oscilloscope, the ADS7000 series, was launched in 2005, SIGLENT has become the fastest growing manufacturer of digital oscilloscopes. We firmly believe that today SIGLENT is the best value in electronic test & measurement.

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SDM3055 Digital Multimeter



SDM3055

SDM3055-SC

Product Overview

The SDM3055/SDM3055-SC is a digital multimeter designed with 5 1/2 digits readings resolution and dual-display, especially fitting to the needs of high-precision, multifunction and automatic measurement.

Application fields

- Research Laboratory
- Development Laboratory
- Repair and Maintenance
- Calibration Laboratory
- Automatic Production Test
- General bench-top use

User-Friendly Design

- 4.3" TFT-LCD, 480*272 display
- Supports dual-display, Chinese and English Menu
- Built-in front panel accessible help system
- File management (support for U-disc and local storage)

Math Function

Basic Measurement Function

- DC Voltage: 200 mV - 1000 V
- DC Current: 200 μ A - 10 A
- AC Voltage: True-RMS, 200 mV - 750 V
- AC Current: True-RMS, 20 mA - 10 A
- 2/4-Wire Resistance: 200 Ω - 100 M Ω
- Capacitance: 2 nF - 10000 μ F
- Continuity Test: Range is fixed at 2 k Ω
- Diode Test: Adjustable range is 0 - 4V
- Frequency Measurement: 20 Hz - 1 MHz
- Period Measurement: 1 μ s - 0.05 s
- Temperature: Support for TC and RTD sensor

Math Function

- Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement, Pass/Fail Histogram, TrendChat

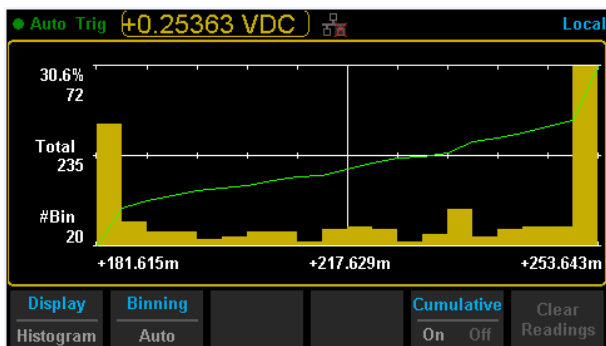
Main Features

- Real 5 1/2 digits readings resolution (240, 000 counts)
- Up to 150 rdgs/s measurement speed
- True-RMS AC Voltage and AC Current measuring
- 1 Gb Nand flash size, Mass storage configuration files and data files
- Built-in cold terminal compensation for thermocouple temperature measurements
- With easy, convenient and flexible PC software: EasyDMM
- standard interfaces: USB Host, LAN (Optional Accessories USB-GPIB Adapter)
- Scanner Card SC1016 (Only for SDM3055-SC)
- Support remote control operation via SCPI commands. Compatible with commands of main stream multimeters

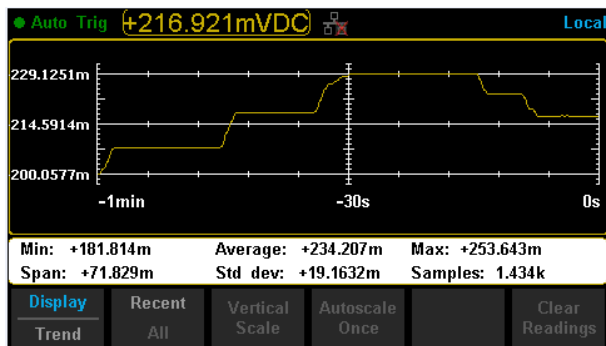


Special Features

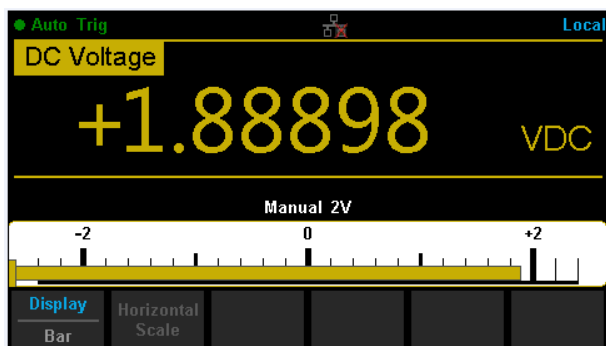
Histogram



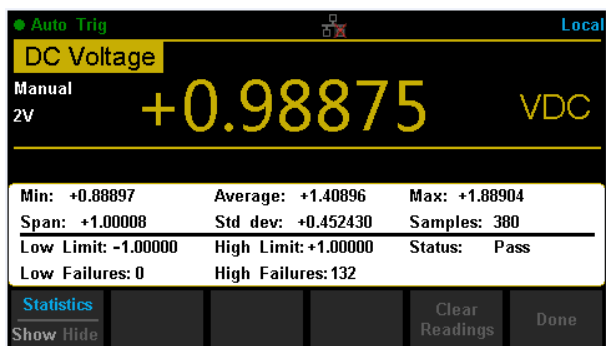
Trend Chart



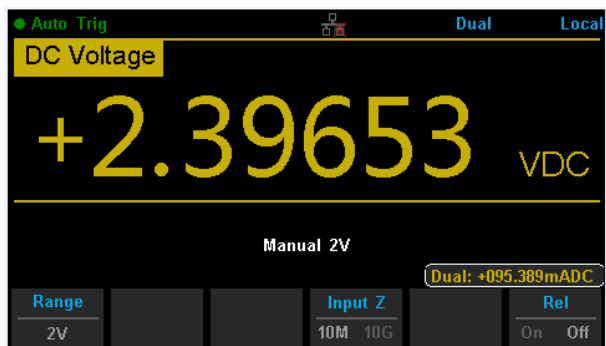
Bar Chart



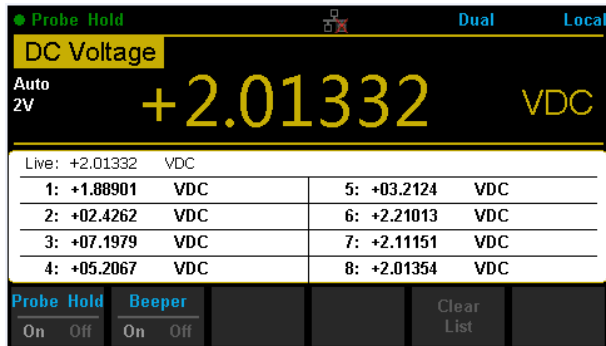
Statistics



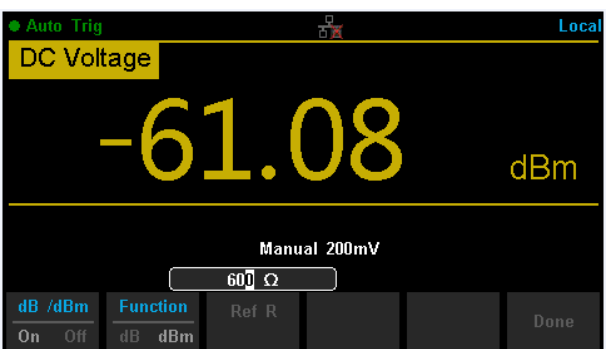
Dual Display



Hold Measurement



dBm Hold Measurement



Interface



Specifications

DC Characteristics

Accuracy \pm (% of Reading + % of Range) ^[1]

Function	Range ^[2]	Test current or Load voltage	1 Year 23 °C \pm 5 °C	Temperature coefficient 0 °C~ 18 °C 28 °C~ 50 °C
DC Voltage	200 mV		0.015 + 0.004	0.0015 + 0.0005
	2 V		0.015 + 0.003	0.0010 + 0.0005
	20 V		0.015 + 0.004	0.0020 + 0.0005
	200 V		0.015 + 0.003	0.0015 + 0.0005
	1000 V ^[4]		0.015 + 0.003	0.0015 + 0.0005
DC Current	200 μ A	< 8 mV	0.055 + 0.005	0.003 + 0.001
	2 mA	< 80 mV	0.055 + 0.005	0.002 + 0.001
	20 mA	< 0.05 V	0.095 + 0.020	0.008 + 0.001
	200 mA	< 0.5 V	0.070 + 0.008	0.005 + 0.001
	2 A	< 0.1 V	0.170 + 0.020	0.013 + 0.001
	10 A ^[5]	< 0.3 V	0.250 + 0.010	0.008 + 0.001
Resistance ^[3]	200 Ω	1 mA	0.030 + 0.005	0.0030 + 0.0006
	2 K Ω	1 mA	0.020 + 0.003	0.0030 + 0.0005
	20 K Ω	100 μ A	0.020 + 0.003	0.0030 + 0.0005
	200 K Ω	10 μ A	0.020 + 0.010	0.0030 + 0.0005
	2 M Ω	1 μ A	0.040 + 0.004	0.0040 + 0.0005
	10 M Ω	200 nA	0.250 + 0.003	0.0100 + 0.0005
	100 M Ω	200 nA 10 M Ω	1.75 + 0.004	0.2000 + 0.0005
Diode Test	2.0 V ^[6]	1 mA	0.05 + 0.01	0.0050 + 0.0005
	4V	100 μ A	0.05 + 0.01	0.0050 + 0.0005
Continuity Test	2000 Ω	1 mA	0.05 + 0.01	0.0050 + 0.0005

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18 °C~ 28 °C.

[2] 20% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. $\pm 0.2 \Omega$ of extra errors will be generated if perform 2-wire measure without " REF " operation.

[4] Plus 0.02 mV of error per 1 V after the first ± 500 VDC.

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[6] Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply.

AC Characteristics

Function	Range ^[2]	Frequency Range	1 Year 23 °C \pm 5 °C	Temperature coefficient 0 °C~ 18 °C 28 °C~ 50 °C
True-RMS AC Voltage ^[3]	200 mV	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz –100 KHz	3.0 + 0.05	0.05 + 0.010
	2 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz –100 KHz	3.0 + 0.05	0.05 + 0.010
	20 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz –100 KHz	3.0 + 0.05	0.05 + 0.010
	200 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz –100 KHz	3.0 + 0.05	0.05 + 0.010
	750 V	20 Hz – 45 Hz	1.5 + 0.10	0.01 + 0.005
		45 Hz – 20 KHz	0.2 + 0.05	0.01 + 0.005
		20 KHz – 50 KHz	1.0 + 0.05	0.01 + 0.005
		50 KHz –100 KHz	3.0 + 0.05	0.05 + 0.010
True-RMS AC Current ^[4]	20 mA	20 Hz – 45 Hz	1.5 + 0.10	0.015 + 0.015
		45 Hz – 2 KHz	0.50 + 0.10	0.015 + 0.006
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.006
	200 mA	20 Hz – 45 Hz	1.5 + 0.10	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.10	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005
	2 A	20 Hz – 45 Hz	1.5 + 0.20	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.20	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005
	10 A ^[5]	20 Hz – 45 Hz	1.5 + 0.15	0.015 + 0.005
		45 Hz – 2 KHz	0.50 + 0.15	0.015 + 0.005
		2 KHz – 10 KHz	2.50 + 0.20	0.015 + 0.005

Additional wave crest factor error (not Sine) ^[6]

Wave crest coefficient	Error (% Range)
1 - 2	0.05
2 - 3	0.2

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18 °C~28 °C.

[2] 20% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and < 50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.

[4] Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5% .

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[6] For frequency < 100Hz



Frequency and Period Characteristic

Accuracy± (% of Reading + % of Range)^[1]

Function	Range	Frequency Range	1 Year 23 °C±5 °C	Temperature coefficient 0 °C~ 18 °C 28 °C~ 50 °C
Frequency /Period	200 mV ~750 V ^[2]	20 Hz – 2 KHz	0.01+0.003	0.002+0.001
		2 KHz – 20 KHz	0.01+0.003	0.002+0.001
		20 KHz – 200 KHz	0.01+0.003	0.002+0.001
		200 KHz –1 MHz	0.01+0.006	0.002+0.002

Remarks:

[1] Specifications are for 0.5 Hour warm-up.

[2] Except for special marks, the AC input voltage is 15% to 120% of range when < 100 kHz and 30% to 120% of range when > 100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of reading when the measurement range of AC voltage is in 200 mV range

Capacitance Characteristic

Accuracy± (% of Reading + % of Range)^[1]

Function	Range ^[2]	Max Testing Current	1 Year 23 °C±5 °C	Temperature coefficient 0 °C~ 18 °C 28 °C~ 50 °C
Capacitance	2 nF	200 nA	3 + 1.0	0.08 + 0.002
	20 nF	200 nA	1 + 0.5	0.02 + 0.001
	200 nF	2 μA	1 + 0.5	0.02 + 0.001
	2 μF	10 μA	1 + 0.5	0.02 + 0.001
	200 μF	100 μA	1 + 0.5	0.02 + 0.001
	10000 μF	1 mA	2 + 0.5	0.02 + 0.001

Remarks:

[1] Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors.

[2] Specifications are for from 1% to 120% on 2 nF range and ranges from 10% to 120% on other ranges.

Temperature Characteristic

Accuracy± (% of Reading + % of Range)^[1]

Function	Probe Type	Probe Model	Working Temperature Range	1Year 23 °C±5 °C	Temperature coefficient 0 °C~18 °C 28 °C~50 °C
Temperature	RTD ^[2]	a = 0.00385	-200 °C ~ 660 °C	0.16 °C	0.08 + 0.002
	TC ^[3]	B	0 °C ~ 1820 °C	0.76 °C	0.14 °C
		E	-270 °C ~ 1000 °C	0.5 °C	0.02 °C
		J	-210 °C ~ 1200 °C	0.5 °C	0.02 °C
		K	-270 °C ~ 1372 °C	0.5 °C	0.03 °C
		N	-270 °C ~ 1300 °C	0.5 °C	0.04 °C
		R	-270 °C ~ 1768 °C	0.5 °C	0.09 °C
		S	-270 °C ~ 1768 °C	0.6 °C	0.11 °C
		T	-270 °C ~ 400 °C	0.5 °C	0.03 °C

Remarks:

[1] Specifications are for 0.5 Hour warm-up, not include probe error.

[2] Specifications are for 4-wire measure or 2-wire measure under " REF " operation.

[3] Built-in cold terminal compensation for thermocouple, accuracy is ± 2 °C.

Measuring Method and other Characteristics

DC Voltage	
Input Resistance	200 mV and 2 V Range 10 M Ω or >10 G Ω selectable
	20 V, 200 V and 1000 V Range 10 M Ω \pm 2%
Input Bias Current	< 90 pA, 25 $^{\circ}$ C
Input Protection	1000 V on all ranges
CMRR	120 dB (For the 1 K Ω unbalanced resistance in LO lead, max \pm 500 VDC)
NMRR	60 dB at " slow " measurement rate
	20 dB are added if open the "AC" filter.
Resistance	
Testing Method	4-wire resistance or 2-wire resistance selectable
Input Protection	1000 V on all ranges
DC Current	
Shunt Resistor	200 μ A sampling voltage < 8 mV
	2 mA sampling voltage < 8 mV
	1 Ω for 20 mA, 200 mA 1 Ω
	0.01 Ω for 2 A, 10 A
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse Internal :12 A,250 V slow-melt fuse
Continuity/Diode Test	
Measurement Method	1 mA \pm 5% constant-current source or open-circuit voltage
Beeper	yes
Continuity Threshold	Adjustable
Input Protection	1000 V
True-RMS AC Voltage	
Measurement Method	AC Coupled true RMS measure – up to 1000 V DC bias are permitted on every range.
Wave Crest Factor	\leq 3 at full scale
Input Impedance	1 M Ω \pm 2% in parallel with <100 pF on all ranges
AC Filter Bandwidth	20 Hz \sim 100 KHz
CMRR	60 dB (For the 1 K Ω imbalance resistance among Lo lead and <60 Hz, Max \pm 500 VDC)
True-RMS AC Current	
Measurement Method	DC Coupled to the fuse and shunt; AC Coupled the True-RMS measurement (measures the AC components only)
Wave Crest Factor	\leq 3 at full scale
Max Input	<10 A (include DC component)
Shunt Resistor	1 Ω for 20 mA, 200 mA 1 Ω ; 0.01 Ω for 2 A, 10 A
Input Protection	Rear panel : accessible 10 A,250 V fast-melt fuse Internal :12 A,250 V slow-melt fuse
Frequency/Period	
Measurement Method	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function
Measure Attentions	Errors are leaded into all frequency counters when measuring low voltage or loe frequency signal.

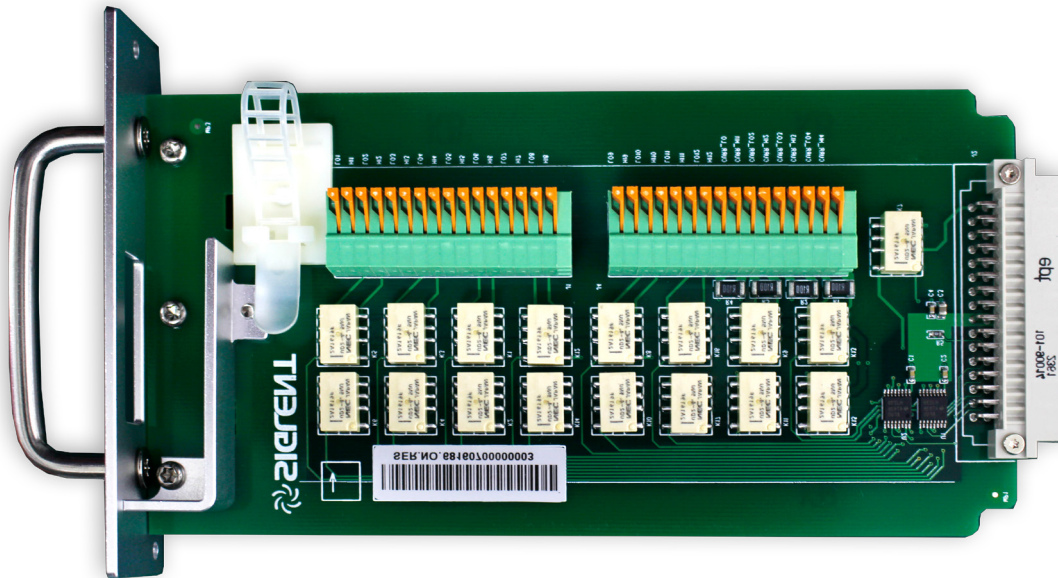
Capacitance Measuring		
Measurement Method	Measure the rate of change of voltage generated during the current flowing the capacitance	
Connection Type	2-wire	
Input Protection	1000 V on all ranges	
Temperature Measuring		
Measurement Method	Support for TC and RTD types of sensor	
Measurement considerations	The built-in cold junction temperature tracks the temperature inside the banana jack. The change of the temperature in banana jack may cause additional error. When using the built-in cold junction compensation, connect the sensor terminal of the thermocouple to the banana jack and allow it warm up for more than 3 minutes to minimize the error.	
Trigger and Memory		
Samples/Trigger	1 ~ 10000	
Trigger Delay	6 ms ~ 10000 ms optional	
External Trigger Input	Input Level	TTL compatible (High level when left input terminal is hanging in the air)
	Trigger Condition	Rising and Falling selectable
	Input Impedance	$\geq 20\text{ K}\Omega/400\text{ pF}$, DC-coupled
	Min Pulse	500 us
VMC	Level	TTL compatible
	Output Polarity	Positive and negative optional
	Output Impedance	200 Ω , typical
History Records		
Volatile Memory	10 K reading of history records	
Nonvolatile Memory	1 Gb Nand Flash, Mass storage configuration files and data files, Support U-disk external storage	
Math Functions		
Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, histogram, Trend chart, Bar chart		

General Specifications

Power Supply	
AC 100 V ~ 120 V	50/60 Hz
AC 200 V ~ 240 V	50/60 Hz
Consumption	20 VA max
Mechanism	
Dimension	282 mm × 260 mm × 105 mm
Weight	3.33 Kg
Other Characteristics	
Display Screen	4.3" TFT-LCD with resolution 480 * 272
Operation Environment	Full accuracy from 0 °C to 50 °C, 80% RH and 40 °C, non condensing
	Storage Temperature: -20 °C - 70 °C
	Shock and Vibration: conforming to MIL-T-28800E, 5 level (only for sine)
	Height above sea level: up to 3000 meters
Safety	Conforming to IEC61010-1:2001. Measure CAT I 1000 V/CAT II 600V Class of pollution: 2
Remote Interface	USB-GPIB, 10/100 Mbit LAN, USB2.0 Full Speed Device&Host
Programing Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	30 minutes

Scanner card SC1016 (Only for SDM3055-SC)

The SIGLENT Scanner Card SC1016 is a multiplexer that provides multi-point measurement capabilities to the SDM3055-SC. The scanner features 12 multi-purpose + 4 current channels and supports the following measurement functions: DCV, ACV, DCI, ACI, 2WR, 4WR, CAP, FREQ, DIODE, CONT and TEMP (RTD and Thermocouple). It provides a convenient and versatile solution for test applications that require multiple measurement points or signals and is an ideal tool for R&D burn-in and production testing.



Specifications

To achieve the best performance from the product, please read this guide carefully.

Max AC Voltage	125 rms or 175 V peak, 100kHz, 0.3 A switched, 125VA (resistive load)
Contact Life	> 100000 operations, at 1 A 30VDC (at 0.5Hz) > 100000 operation, at 0.3 A 125VDC (at 0.5Hz)
Contact Resistance	75 mΩ (maximum at 6 VDC, 1A)
Actuation Time	180ms maximum on/off (channel to channel)
Maximum switching voltage	250 VAC, 220 VDC
Maximum switching power	62.5 VA / 30W
Insulation Resistance	Minimum 1 GΩ
Connect Type	Clamp terminal, # 24 AWG wire size

Remark: To avoid electrical shock and personal injury, please don't use the product to measure signals that published specification.

Channel Capabilities

Item	No. of wires	No. of channels
DCV \ ACV ^[1]	2 wires (H, L)	12 (CH1 ~ CH12)
DCI \ ACI ^[2]	2 wires (H, L)	4 (CH13 ~ CH16) (2A Range)
2 W Resistance	2 wires (H, L)	12 (CH1 ~ CH12)
Capacitance	2 wires (H, L)	12 (CH1 ~ CH12)
Diode / Continuity	2 wires (H, L)	12 (CH1 ~ CH12)
Period / Frequency	2 wires (H, L)	12 (CH1 ~ CH12)
Temp (Thermocouple)	2 wires (H, L)	12 (CH1 ~ CH12)
Temp (RTD)	2 wires (H, L)	12 (CH1 ~ CH12)

Remark:[1] Voltage range: < 125 VAC, 100 V DC

[2] For continuous current < 2.2 A, Accuracy \pm (% 3 (reading) + 0.02% (range)).

Product Model and Distinction

Model	SDM3055	SDM3055-SC
Scanner card SC1016	×	√

Ordering Information

Standard Accessories	
Power Cord -1	
USB Cable -1	
Quick Start -1	
Warranty Card -1	
EasyDMM ^[1]	Software
Test Leads and Alligator Clips -2	
Optional Accessories	
USB-GPIB	USB-GPIB adapter

[1]The latest version of EasyDMM can be downloaded for free from the SDM3000 series of digital multimeter. Please see our web site at www.siglent.com for more information

SDM3045X Digital Multimeter



Product Overview

SDM3045X is a 4½ digit digital (60000 count) multimeter incorporating a dual-display and is especially well suited for the needs of high-precision, multifunction and automatic measurement.

Main Function

Basic Measurement Function

- ⚡ DC Voltage: 600 mV - 1000 V
- ⚡ DC Current: 600 μ A - 10 A
- ⚡ AC Voltage: True-RMS, 600 mV - 750 V
- ⚡ AC Current: True-RMS, 60 mA - 10 A
- ⚡ 2/4-Wire Resistance: 600 Ω - 100 M Ω
- ⚡ Capacitance: 2 nF - 10000 μ F
- ⚡ Continuity Test: Range is fixed at 2 k Ω
- ⚡ Diode Test: Adjustable range is 0-4 V.
- ⚡ Frequency Measurement: 20 Hz - 500 KHz
- ⚡ Period Measurement: 2 μ s - 0.05 s
- ⚡ Temperature: Support for TC and RTD sensor
- ⚡ Max, Min, Average, Standard Deviation, dBm/dB, Relative Measurement ,Pass/Fail Histogram, Trend Chart

User-friendly Design

4.3" TFT-LCD, 480*272

Support dual display, Chinese and English Menu

Built-in front panel accessible help system

File management (support for U-disc and local storage)

Application fields

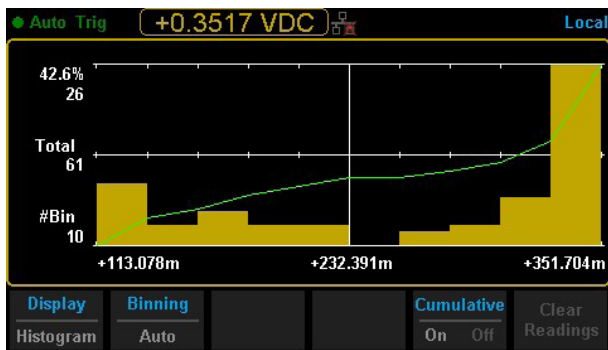
- ⚡ Research Laboratory
- ⚡ Development Laboratory
- ⚡ Detection and Maintenance
- ⚡ Calibration Laboratory
- ⚡ Automatic Production Test

Main Features

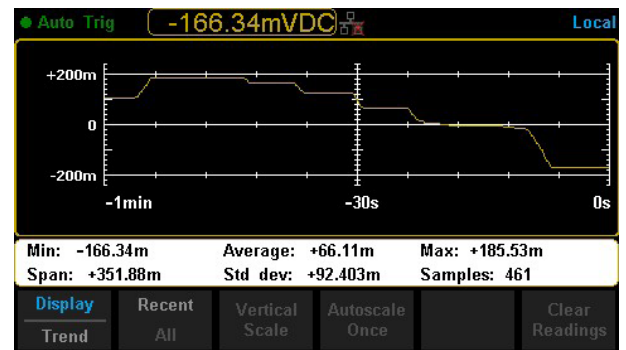
- ⚡ Real 4½ digit (66000 count) readings resolution
- ⚡ Up to 150 rdgs/s measurement speed
- ⚡ True-RMS AC Voltage and AC Current measuring
- ⚡ 1 Gb NAND flash size, Mass storage configuration files and data files
- ⚡ Built-in cold terminal compensation for thermocouple
- ⚡ With easy, convenient and flexible PC software: EasyDMM
- ⚡ Standard interface: USB Device, USB Host, LAN (Optional Accessories: USB-GPIB Adapter)
- ⚡ USB & LAN remote interfaces support common SCPI command set. Compatible with other popular DMMs on the market.

Special Features

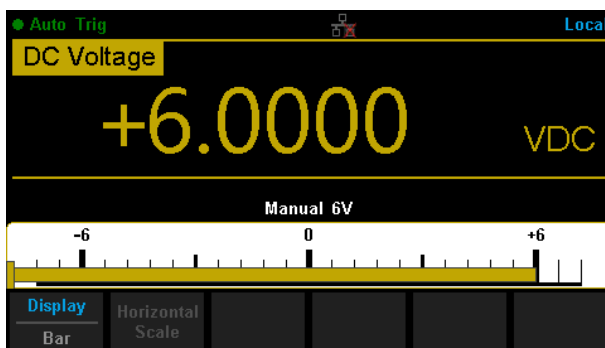
Histogram



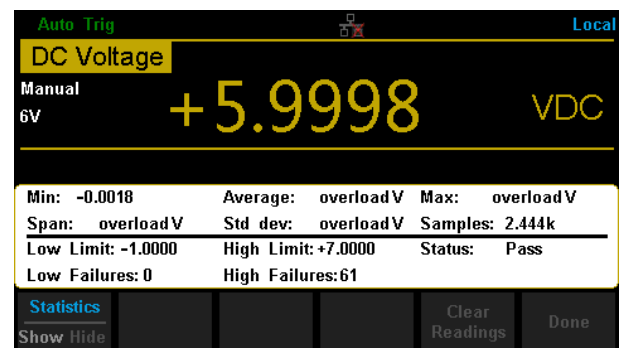
Trend Chart



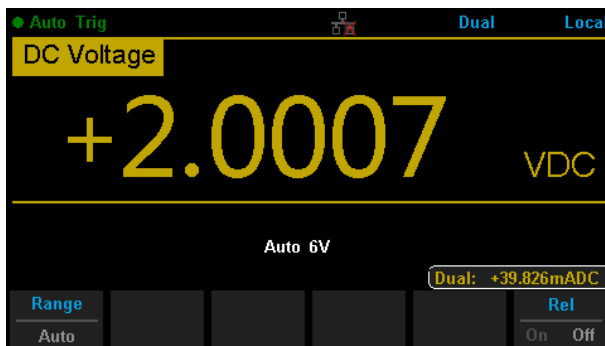
Bar Chart



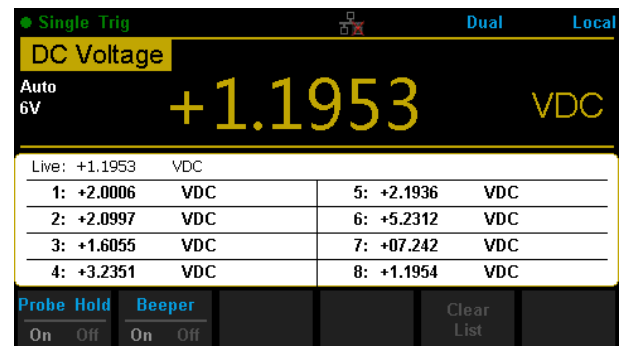
Statistics



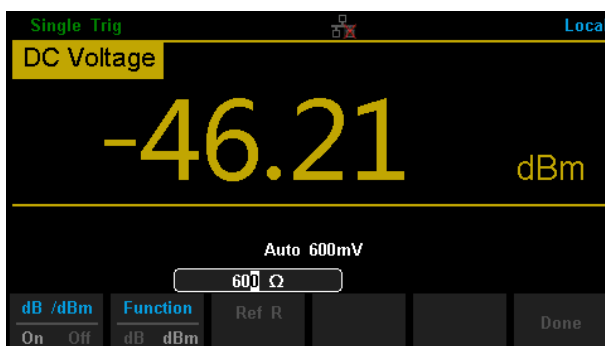
Dual Display



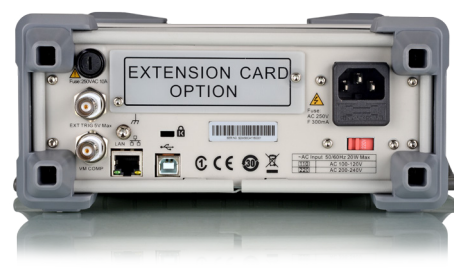
Hold Measurement



dBm Hold Measurement



Interface



Specifications

DC Characteristics

Accuracy ± (% of Reading + count)^[1]

Function	Range ^[2]	Test current or Load voltage	Resolution	Accuracy (one year; 23°C ±5°C)
DC Voltage	600 mV		0.01 mV	0.02+ 6
	6 V		0.0001 V	0.02+ 6
	60 V		0.001 V	0.02+ 6
	600 V		0.01 V	0.02+ 6
	1000 V ^[4]		0.1 V	0.02+ 6
DC Current	600 µA	< 33 mV	0.01 µA	0.05+ 3
	6 mA	< 330 mV	0.0001 mA	0.05+ 3
	60 mA	< 0.05 V	0.001 mA	0.05+ 3
	600 mA	< 0.5 V	0.01 mA	0.12+ 6
	6 A	< 0.33 V	0.0001 A	0.20+ 5
	10 A ^[5]	< 0.6 V	0.001 A	0.25+ 4
Resistance ^[3]	600 Ω	1 mA	0.01 Ω	0.08+ 6
	6 KΩ	1 00 µA	0.0001 KΩ	0.04+ 6
	60 KΩ	10 µA	0.001 KΩ	0.04+ 6
	600 KΩ	1 µA	0.01 KΩ	0.08+ 6
	6 MΩ	200 nA	0.0001 MΩ	0.12+ 3
	60 MΩ	200 nA 10 MΩ	0.001 MΩ	0.85+ 3
	100 MΩ	200 nA 10 MΩ	0.01 MΩ	1.75+ 3
Diode Test ^[6]	0-2 V	1 mA	0.0001 V	0.05+ 3
	2-4 V	1 mA	0.0001 V	0.35+ 3
Continuity Test	2000 Ω	1 mA	0.1 Ω	0.05+ 3

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C - 28°C .

[2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for 4-wire measure or 2-wire measure under "REF" operation. ±0.2 Ω of extra errors will be generated if perform 2-wire measure without "REF" operation.

[4] Plus 0.02 mV of error per 1 V after the first ±500 VDC.

[5] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[6] Accuracy specifications are only for voltage measuring at input terminal. The typical value of current under measure is 1 mA. Voltage drop at diode junction may vary with current supply. Adjustable voltage range : 0- 4 V.



AC Characteristics

Accuracy± (% of Reading + count)¹⁾

Function	Range ^[2]	Frequency Range	Resolution	Accuracy (one year; 23°C ±5°C)
True-RMS AC Voltage ^[3]	600 mV	20 Hz – 45 Hz	0.01 mV	2.0 + 20
		45 Hz – 100 Hz	0.01 mV	0.6 +10
		100 Hz – 20 KHz	0.01 mV	0.3 + 20
		20 KHz – 50 KHz	0.01 mV	2.0 + 40
		50 KHz –100 KHz	0.01 mV	3.0 + 10
	6 V	20 Hz – 45 Hz	0.0001 V	2.0 + 20
		45 Hz – 100 Hz	0.0001 V	0.6 + 10
		100 Hz – 20 KHz	0.0001 V	0.8 + 20
		20 KHz – 50 KHz	0.0001 V	2.0 + 40
		50 KHz –100 KHz	0.0001 V	3.0 + 40
	60 V	20 Hz – 45 Hz	0.001 V	2.0 + 20
		45 Hz – 100 Hz	0.001 V	0.6 + 10
		100 Hz – 20 KHz	0.001 V	0.8 + 20
		20 KHz – 50 KHz	0.001 V	2.0 + 40
		50 KHz –100 KHz	0.001 V	3.0 + 40
	600 V	20 Hz – 45 Hz	0.01 V	2.0 + 20
		45 Hz – 100 Hz	0.01 V	0.6 + 10
		100 Hz – 20 KHz	0.01 V	0.8 + 20
		20 KHz – 50 KHz	0.01 V	2.0 + 40
		50 KHz –100 KHz	0.01 V	3.0 + 40
750 V	20 Hz – 45 Hz	0.01 V	2.0 + 20	
	45 Hz – 100 Hz ^[4]	0.01 V	0.6 + 10	
	100 Hz – 20 KHz	0.01 V	0.8 + 20	
	20 KHz – 50 KHz	0.01 V	2.0 + 40	
	50 KHz –100 KHz	0.01 V	3.0 + 40	
True-RMS AC Current ^[5]	60 mA	20 Hz – 45 Hz	0.001 mA	2.0 + 20
		45 Hz – 2 KHz	0.001 mA	0.5 + 20
		2 KHz – 10 KHz	0.001 mA	2.5 + 30
	600 mA	20 Hz – 45 Hz	0.01 mA	2.0 + 20
		45 Hz – 2 KHz	0.01 mA	0.5 + 20
		2 KHz – 10 KHz	0.01 mA	2.5 + 30
	6 A	20 Hz – 45 Hz	0.0001 A	2.0 + 20
		45 Hz – 2 KHz	0.0001 A	0.5 + 20
		2 KHz – 10 KHz	0.0001 A	2.5 + 20
	10 A ^[6]	20 Hz – 45 Hz	0.001 A	1.5 + 45
		45 Hz – 2 KHz	0.001 A	0.5 + 35
		2 KHz – 10 KHz	0.001 A	2.5 + 25

Additional wave crest factor error (not Sine) ^[7]

Wave crest coefficient	Error (% Range)
1-2	0.05
2-3	0.3

Remarks:

[1] Specifications are for 0.5 Hour warm-up, "Slow" measurement rate and calibration temperature 18°C - 28°C .

[2] 10% over range on all ranges except for DCV 1000 V, ACV 750 V, DCI 10 A and ACI 10 A.

[3] Specifications are for amplitude of sine wave input > 5% of range. For inputs from 1% to 5% of range and <50 kHz, add 0.1% of range extra error. For 50 kHz to 100 kHz, add 0.1% of range extra error.

[4] Plus 0.025 V of error per 1 V after the first ±400 VAC.

[5] Specifications are for sine wave input > 5% of range. 0.1% errors will be added when the range of input sine wave is 1% to 5%.

[6] 30 seconds OFF after 30 seconds ON is recommend for the continuous current that higher than DC 7 A or AC RMS 7 A.

[7] For inputs Frequency Range < 100 Hz

Frequency and Period Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range	Frequency Range	Resolution	Accuracy (one year; 23°C ±5°C)
Frequency /Period	600 mV to 750 V ^[2]	20 Hz – 2 KHz		0.01+3
		2 KHz – 20 KHz		0.01+2
		20 KHz – 200 KHz		0.01+2
		200 KHz –500 KHz		0.01+2

Remarks:

[1] Specifications are for 0.5 Hour warm-up.

[2] Except for special marks, the AC input voltage is 5% to 110% of range when <100 kHz and 10% to 110% of range when >100 kHz. 750 V range is limited to 750 Vrms. The accuracy is 10 times % of Reading when the measurement range of AC voltage is in 600 mV range.

Capacitance Characteristic

Accuracy± (% of Reading + count)^[1]

Function	Range ^[2]	Max Testing Current	Resolution	Accuracy (one year; 23°C ±5°C)
Capacitance	2 nF	10 µA	0.001 nF	3+10
	20 nF	10 µA	0.01 nF	1+10
	200 nF	100 µA	0.1 nF	1+9
	2 µF	100 µA	0.001 µF	1+10
	20 µF	1 mA	0.01 µF	1+10
	200 µF	1 mA	0.1 µF	1+9
	10000 µF	1 mA	1 µF	2+50

Remarks:

[1] Specifications are for 0.5 Hour warm-up and "REF" operation. Using of non-film capacitor may generate additional errors.

[2] Specifications are for from 1% to 110% on 2 nF range and ranges from 10% to 110% on other ranges.

Temperature Characteristic

Accuracy± (% of Reading)^[1]

Function	Probe Type	Probe Model	Working Temperature Range	Accuracy (one year; 23°C ±5°C)	Temperature coefficient 0°C - 18°C 28°C - 5 0°C
Temperature	RTD ^[2]	α=0.00385	-200°C - 660°C	0.16°C	0.09°C
		B	0°C - 1820°C	0.76°C	0.14°C
	TC ^[3]	E	-270°C - 1000°C	0.5°C	0.02°C
		J	-210°C - 1200°C	0.5°C	0.02°C
		K	-270°C - 1370°C	0.5°C	0.03°C
		N	-270°C - 1300°C	0.5°C	0.04°C
		R	-50°C - 1760°C	0.5°C	0.09°C
		S	-50°C - 1760°C	0.6°C	0.11°C
		T	-270°C - 400°C	0.5°C	0.03°C

Remarks:

[1] Specifications are for 0.5 Hour warm-up, not include probe error.

[2] Specifications are for 4-wire measure or 2-wire measure under "REF" operation.

[3] Built-in cold terminal compensation for thermocouple, accuracy is ±2°C .

Measuring Method and other Characteristics

DC Voltage		
Input Resistance	600 mV	10 M Ω or 10 G Ω selectable
	6 V, 60 V, 600 V and 1000 V Range	10 M Ω \pm 2%
Input Bias Current	<90 pA, 25°C	
Input Protection	1000 V on all ranges	
CMRR	120 dB (For the 1 K Ω unbalanced resistance in LO lead, max \pm 500 VDC)	
NMRR	60 dB at "slow" measurement rate	
Resistance		
Testing Method	4-wire resistance or 2-wire resistance selectable	
Input Protection	1000 V on all ranges	
DC Current		
Shunt Resistor	600 μ A sampling voltage < 33 mV	
	6 mA sampling voltage < 0.33 V	
	1 Ω for 60 mA, 600 mA 1 Ω	
	0.01 Ω for 6 A, 10 A	
Input Protection	Rear panel : accessible 10 A, 250 V fast-melt fuse	
	Internal : 12 A, 250 V slow-melt fuse	
Continuity/Diode Test		
Measurement Method	1 mA \pm 5% constant-current source or open-circuit voltage	
Beeper	yes	
Continuity Threshold	Adjustable	
Input Protection	1000 V	
True-RMS AC Voltage		
Measurement Method	AC Coupled true RMS measure – up to 1000 V DC bias are permitted on every range.	
Wave Crest Factor	\leq 3 at full scale	
Input Impedance	1 M Ω \pm 2% in parallel with <100 pF on all ranges	
AC Filter Bandwidth	20 Hz - 100 KHz	
CMRR	60 dB (For the 1 K Ω imbalance resistance among Lo lead and <60 Hz, Max \pm 500 VDC)	
True-RMS AC Current		
Measurement Method	DC Coupled to the fuse and shunt; AC Coupled the True-RMS measurement (measures the AC components only)	
Wave Crest Factor	\leq 3 at full scale	
Max Input	<10 A (include DC component)	
Shunt Resistor	1 Ω for 60 mA, 600 mA 1 Ω ; 0.01 Ω for 6 A, 10 A	
Input Protection	Rear panel : accessible 10 A, 250 V fast-melt fuse	
	Internal : 12 A, 250 V slow-melt fuse	
Frequency/Period		
Measurement Method	Reciprocal-counting technique, AC Coupled input, AC voltage or AC current measurement function	
Measure Attentions	errors are leaded into all frequency counters when measuring low voltage or low frequency signal.	
Capacitance Measuring		
Measurement Method	Measure the rate of change of voltage generated during the current flowing the capacitance	
Connection Type	2-wire	
Input Protection	1000 V on all ranges	
Temperature Measuring		
Measurement Method	Support for TC and RTD types of sensor	
Trigger and Memory		
Samples/Trigger	1 - 10000	
Trigger Delay	6 ms - 10000 ms optional	
External Trigger Input	Input Level	TTL compatible (High level when left input terminal is hanging in the air)
	Trigger Condition	Rising and Falling selectable
	Input Impedance	\geq 20 K Ω //400 pF ,DC-coupled
	Min Pulse	500 us
VMC	Level	TTL compatible
	Output Polarity	Positive and negative optional
	Output Impedance	200 Ω , typical

History Records

Volatile Memory	10 K reading of history records
Nonvolatile Memory	1 Gb Nand Flash, Mass storage configuration files and data files, Support U-disk external storage

Math Functions

Min/Max/Average, dBm, dB, Pass/Fail, Relative, Standard deviation, Hold, histogram, Trend chart, Bar chart

General Specifications

Power Supply

AC 100 V - 120 V	45 Hz - 66 Hz
AC 200 V - 240 V	45 Hz - 66 Hz
Consumption	20VA max

Mechanism

Dimension	293.75 mm×260.27 mm×107.21 mm
Weight	3.76 Kg

Other Characteristics

Display Screen	4.3" TFT-LCD with resolution 480*272
Operation Environment	Full accuracy from 0°C to 50°C , 80% RH and 40°C , non condensing
	Storage Temperature: -20°C -70°C
	Shock and Vibration: conforming to MIL-T-28800E, , 5 level (only foe sine)
	Height above sea level: up to 3000 meters
electromagnetic compatibility	Conforming to EMC (2004/108/EC) and EN 61326-1:2013
Safety	Conforming to EN61010-1:2010 and low voltage instructions (2006/95/EC)
Remote Interface	10/100 Mbit LAN, USB2.0 Full Speed Device and Host
Programmer Language	Standard SCPI, compatible with commands of main stream multimeters
Warm Up Time	30 minutes

Purchase Information

Standard Accessories

Power Cord	-1	
USB Cable	-1	
Quick Start	-1	
warranty Card	-1	
EasyDMM ^[1]		software system
Test Leads and Alligator Clips	-2	

Optional Accessories

USB-GPIB adapter	USB-GPIB
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[1] The latest version of EasyDMM can be downloaded for free from the SDM3000 series of digital multimeter. Please see our web site at www.siglent.com for more information

SDM3045X Digital Multimeter

About SIGLENT

SIGLENT is an international high-tech company, concentrating on R&D, sales, production and services of electronic test & measurement instruments.

SIGLENT first began developing digital oscilloscopes independently in 2002. After more than a decade of continuous development, SIGLENT has extended its product line to include digital oscilloscopes, function/arbitrary waveform generators, digital multimeters, DC power supplies, spectrum analyzers, isolated handheld oscilloscopes and other general purpose test instrumentation. Since its first oscilloscope, the ADS7000 series, was launched in 2005, SIGLENT has become the fastest growing manufacturer of digital oscilloscopes. We firmly believe that today SIGLENT is the best value in electronic test & measurement.

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